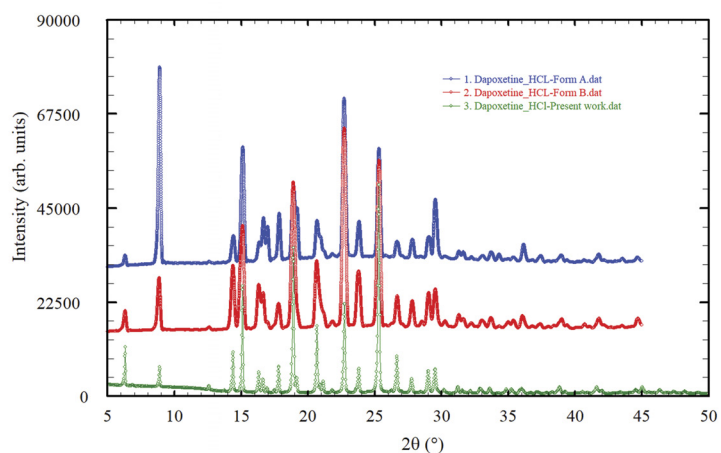
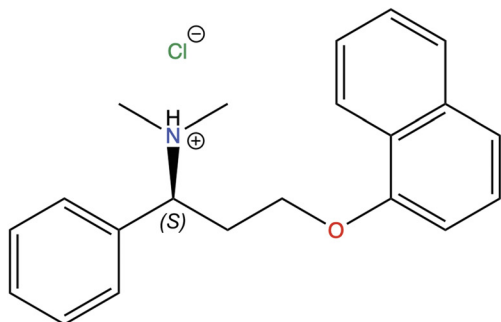


# Powder Diffraction PDJ

*Journal of Materials Characterization*

(S)-Dapoxetine Hydrochloride  
Molecular Diagram and PXRD Pattern



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## **Powder Diffraction**

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### **Aims & Scope**

ICDD's quarterly, and special topical issue, international journal, *Powder Diffraction*, focuses on materials characterization employing X-ray powder diffraction and related techniques. With feature articles covering a wide range of applications, from mineral analysis to epitaxial growth of thin films to advances in application software and hardware, this journal offers a wide range of practical applications. ICDD, in collaboration with the Denver X-ray Conference Organizing Committee, has increased services for the subscribers of Powder Diffraction and authors of Advances in X-ray Analysis. Beginning in 2006, ICDD offered a copy of the previous year's edition of AXA to Powder Diffraction institutional subscribers who receive both print and on-line versions. This effectively doubles the number of articles annually available to Powder Diffraction subscribers and significantly increases the circulation for the authors in Advances in X-ray Analysis.

### **Subject coverage includes:**

- Techniques and procedures in X-ray powder diffractometry
- Advances in instrumentation
- Study of materials including organic materials, minerals, metals and thin film superconductors
- Publication of powder data on new materials

### **International Centre for Diffraction Data**

The International Centre for Diffraction Data (ICDD®) is a non-profit scientific organization dedicated to collecting, editing, publishing, and distributing powder diffraction data for the identification of materials. The membership of the ICDD consists of worldwide representation from academe, government, and industry.

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**On the Cover:** In the manuscript "Crystal structure from laboratory X-ray powder diffraction data, DFT-D calculations, and Hirshfeld surface analysis of (S)-Dapoxetine Hydrochloride by Analio J. Dugarte-Dugarte, Robert A. Toro, Jacco van de Streek, Jose Antonio Henao, Graciela Diaz de Delgado, Jose Miguel Delgado the authors presented a thorough analysis of the structure of this active pharmaceutical ingredient and compared it to patterns reported in patents (Form A and Form B).

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[www.icdd.com/xrd](http://www.icdd.com/xrd)



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## Rietveld Refinement & Indexing Clinic:

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**Please note:** A minimum of 10 registrants per course is required, otherwise the course will be cancelled and your registration fee will be refunded. You will be notified of a course cancellation no later than two weeks prior to the start of the course.

## For More Information Contact:

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ICDD for over *80 years* has been dedicated to collecting, editing, publishing, and distributing powder diffraction data for the identification of crystalline materials. To assist us in this growth, ICDD has called on researchers from around the world to contribute their experimental data. In return, ICDD supports their efforts by funds provided through our Grant-in-Aid Program.

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